Application/Control No. Applicant(s)/Patent Under Reexamination 10/613,758 SCHMIDT ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Thien M. Le 2876 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2004/0049884 03-2004 Kim, Si-Wan Α 016/337 US-2002/0107043 08-2002 В Adamson et al. 455/550 С US-US-D US-Ε F US-G US-US-Н US-1 US-J US-Κ US-L М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s

* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

U

W

X

NON-PATENT DOCUMENTS

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Ţ